

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/629,889	KIM ET AL	
Examiner	Art Unit	
Thai D. Hoang	2616	

SEARCHED				
Class	Subclass	Date	Examiner	
370	389- 395.52	3/19/2007	тн	
_	400-409	3/19/2007	ТН	
	419-424	3/19/2007	ТН	
	532-542	`3/19/2007	ТН	
359	118-126	3/19/2007	ТН	
	135-139	3/19/2007	тн	
	152-158	3/19/2007	ТН	
	164-168	3/19/2007	тн	
	180-195	3/19/2007	тн	
		(4)		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST: SEE SEARCH HISTORY PRINTED OUT	3/19/2007	тн
NPL: IEEE, GOOGLE, IETF	3/19/2007	тн
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